Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/735,154	KO, DAVID (TSO-CHIN)
Examiner	Art Unit
Edwin A. León	2833

	SEAR	CHED	
Class	Subclass	Date	Examiner
439 	607-610	4/8/2005	EAL
	660		
	492-495		
	79		
	571-573		
	629		
	108		
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INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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